

2011 Symposium on Counterfeit Electronic Parts - West

**Anaheim, California, USA
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**Counterfeit Electronic Parts &
Electronic Supply Chain Symposium
December 6 – 7, 2011**

Crowne Plaza Anaheim Resort, Garden Grove (Anaheim), CA

Day 1 - December 06, 2011	
Topic	Speaker
Session 1	
Electronics Parts and Subsystems Supply Chain	Diganta Das , CALCE, University of Maryland
The Latest Counterfeit Processes	Tom Sharpe , SMT Corporation (No full version)
Session 2	
Risk Mitigation to Avoid Counterfeit Components	Marty Lanning , XTREME Semiconductor
A Practical Approach to Mitigating the Impact of Counterfeit Components	Dave Looney , Premier Semiconductor Services LLC
Session 3	
Rt qvge v lpi 'Rt qf wevu Ut gpi vj gplpi 'Dt cpf u Uchlgi wct f lpi ' Cugvu 2'	Huda Midani , Schreiner ProSecure
Sustaining the Integrity of Design Engineering with PKI	Admir Abdurahmanovic , PrimeKey Soutlions AB Thomas Arkwright , PhD
Moving Beyond Human Perception for Counterfeit Mitigation	Leonard Nelson , ChromoLogic LLC
Session 4	
FPC'O ct n lpi ' ('Cwj gpvkcv kqp 7'	Janice Meraglia , Applied DNA Science
Integrating Obsolescence with Program Goals to Avoid Counterfeit Components	Denise Lingenfelter , Channel One International
Understanding Applicable Standards in Selecting Electronic Component Vendors	Gary Beckstedt , World Mirco (Not presented at symposium)
Corporate Quality and Services Presentation	Giles Aouizerat , Mark Pappas , PCX Inc.
Day 2 - December 07, 2011	

Session 5

Mitigating Counterfeit Electronic Parts Risk Through Standardized Certification of Distributors (00086:	Philip Zulueta , NASA
Supplier Quality Requirements with Authorized Distribution (Presented by Mark Stander) (00084	Kevin Sink , TTI. Inc. (Presented by Mark Stander)

Session 6

Developing and Implementing an Effective Anti-Counterfeiting Program (0008: 2	Tom Peistrup , Tantal & Adler LLP.
Impact on Gray Market protection and Comparison to IP Laws (0008; 9	Milt Springnut , David Kalow , Kalow & Springnut.
Confronting the Problem of Counterfeit Components from a Legal Perspective (00042:	Keith Gregory , Greenberg & Bass, LLC.

Session 7

Panel Discussion Laser Decapsulation and Counterfeit Detection (000432 Advanced Radiography Topics: Potential Damage to Electronic Components (000443 Non Destructive Methods for the Detection of Counterfeit Parts (000453	Moderator: Bhanu Sood , PhD., CALCE, University of Maryland Panelists: Erik Jordan , Nisene Technology Bill Cardoso , Ph.D., Creative Electron; Katherine Whittington , Honeywell
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Session 8

Counterfeits Made with Harvested Die - How it's Done and Detection (00047:	Robert Hammond , Charles Irvin , American Electronic Resource Inc.
Counterfeit Trends - Increasing Difficulties in Detection (000488	Mark Marshall , Integra Technologies LLC
Non-compliant or Suspect Counterfeit Packaging Materials In the Supply Chain Cannot be Overlooked! (00049:	Bob Vermillion , RMV Technology Group LLC
Closing Remarks (0004; :	Diganta Das , CALCE, University of Maryland

Additional Paper

Stopping Electronics Counterfeits By Cutting Off E-Waste Supply (000524	Barbara Kyle , Electronics TakeBack Coalition
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